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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/606,580	06/26/2003	David William Boerstler	AUS920020690US1	5123
7590		12/02/2004	EXAMINER	
Gregory W. Carr		NATALINI, JEFF WILLIAM		
670 Founders Square		ART UNIT		
900 Jackson Street		PAPER NUMBER		
Dallas, TX 75202		2858		

DATE MAILED: 12/02/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

10/606,580

Applicant(s)

BOERSTLER ET AL.

Examiner

Jeff Natalini

Art Unit

2858

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☐ Responsive to communication(s) filed on ____.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-46 is/are pending in the application.
- 4a) Of the above claim(s) 1-16 and 39-46 is/are withdrawn from consideration.
- 5) ☐ Claim(s) ____ is/are allowed.
- 6) ☒ Claim(s) 17-38 is/are rejected.
- 7) ☐ Claim(s) ____ is/are objected to.
- 8) ☐ Claim(s) ____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☒ The drawing(s) filed on 26 June 2003 is/are: a) ☐ accepted or b) ☒ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
 2. ☐ Certified copies of the priority documents have been received in Application No. ____.
 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- | | |
|---|--|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892) | 4) <input type="checkbox"/> Interview Summary (PTO-413)
Paper No(s)/Mail Date. ____ |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948) | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)
Paper No(s)/Mail Date ____ | 6) <input type="checkbox"/> Other: ____ |

Election/Restrictions

1. Applicant's election without traverse of the species of figure 12, encompassing claims 1-28 and 30-46 is acknowledged. However, it is seen that claims 1-16 and 39-46 are a method, apparatus, and computer program of the method, all based on figure 1. Therefore claims 1-16 and 39-46 will not be examined as they are based on a non-elected species, whereby claims 17-38 are to be examined.

Claims 1-16 and 39-46 are withdrawn from further consideration pursuant to 37 CFR 1.142(b) as being drawn to a nonelected species, there being no allowable generic or linking claim. Election was made **without** traverse in the reply filed on September 28, 2004.

Drawings

2. The drawings are objected to under 37 CFR 1.83(a). The drawings must show every feature of the invention specified in the claims. Therefore, the "N resistors coupled in series between supply voltage and ground" of claim 30, must be shown or the feature(s) canceled from the claim(s). It is understood that the pad (which the picture shows is on the other side of the supply voltage and N resistors) could be grounded, but also could contain a voltage, therefore this inconsistency needs to be corrected. No new matter should be entered.

Corrected drawing sheets in compliance with 37 CFR 1.121(d) are required in reply to the Office action to avoid abandonment of the application. Any amended replacement drawing sheet should include all of the figures appearing on the immediate prior version of the sheet, even if only one figure is being amended. The figure or figure

number of an amended drawing should not be labeled as "amended." If a drawing figure is to be canceled, the appropriate figure must be removed from the replacement sheet, and where necessary, the remaining figures must be renumbered and appropriate changes made to the brief description of the several views of the drawings for consistency. Additional replacement sheets may be necessary to show the renumbering of the remaining figures. The replacement sheet(s) should be labeled "Replacement Sheet" in the page header (as per 37 CFR 1.84(c)) so as not to obstruct any portion of the drawing figures. If the changes are not accepted by the examiner, the applicant will be notified and informed of any required corrective action in the next Office action. The objection to the drawings will not be held in abeyance.

Claim Rejections - 35 USC § 102

3. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

4. Claims 17-21 are rejected under 35 U.S.C. 102(e) as being anticipated by Chien et al. (6597249).

In regard to claim 17, Chien et al. discloses a method for testing a phase locked loop (col 6 line 2-17; a lock is determined) having a phase frequency detector (fig 3

(13)) and a voltage controlled oscillator (fig 3 (15)) receiving input from the PFD comprising: disabling the PFD (col 3 line 59-60); applying a plurality of test input voltages to the VCO and measuring output frequencies of the VCO as a function of the test input voltages (col 3 line 56 – col 4 line 3); determining lock/capture range of the PLL based on the measured output frequencies of the VCO as a function of the test voltages (col 6 line 2-8).

In regard to claim 18, Chien et al. discloses performing a minimal set of tests on the PLL based on the lock/capture range of the PLL (abstract, coarse tuning the VCO speeds up the settling time and matches frequencies (col 6 line 5-6), thus verification of the lock/capture range is done easily with fine tuning (col 6 line 9-13).

In regard to claim 19, Chien et al. discloses wherein the test input voltages include discrete DC voltages (col 3 line 61 – col 4 line 3; in order to output different frequencies from the VCO the input voltage must be changed).

IN regard to claim 20, Chien et al. discloses wherein the test input voltages are applied to the VCO through at least one transmission gate (the coarse tuning block shown in fig 4 (contains 22-comparator among others) it is common knowledge in the art that a comparator is made up of transmission gates (MPEP 2144.03)).

In regard to claim 21, Chien et al. discloses an apparatus for testing a PLL (col 6 line 2-17; a lock is determined) comprising: a PLL (fig 3 (13,14,15,16)) having a phase-frequency detector (fig 3 (13)) and a voltage controlled oscillator (fig 3 (15)) receiving input from the PFD; and a test input voltage generator (fig 3 (10)) coupled to the VCO

for selectively applying a plurality of test input voltages to the VCO while the PFD is disabled (col 3 line 56 - col 4 line 3).

Claim Rejections - 35 USC § 103

5. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

6. Claims 22-24, 29-32 and 37 rejected under 35 U.S.C. 103(a) as being unpatentable over Chien et al. (6597249) in view of Huang et al. (Pub 2003/0071748).

In regard to claims 22-24 and 30-32, Chien et al. lacks wherein the voltage generator comprises: N resistors coupled in series between supply voltage and ground/pad, the N resistors forming N+1 nodes between a supply switch and a pad, the supply switch connecting the N resistors to the supply voltage when turned on, wherein N is an integer greater than or equal to 1; N+1 switches being coupled between an input of the VCO and one of the N+1 nodes; a test scan signal generator coupled to the N+1 switches so that a plurality of test scan signals control the N+1 switches when the PFD is disabled; and a scan-enable switch coupled between the N+1 switches and the input of the VCO to be turned on when the PFD is disabled.

Huang et al. discloses a voltage generator comprising N resistors coupled in series between supply voltage and ground/pad (fig 1 (102,106) has 3 resistors),

the N resistors forming N+1 nodes between a supply switch and a pad (fig 1, 4 nodes are seen between supply and ground; also it is known in the art to have a pad on I/O devices to provide a reference voltage (MPEP 2144.03)),

the supply switch connecting the N resistors to the supply voltage when turned on, wherein N is an integer greater than or equal to 1 (fig 1 (112)), provides this capability as no voltage is allowed into the amplifier until this switch is closed, no functional advantage is provided in the claimed invention that is not in Huang et al.'s voltage generator by having a switch between the voltage generator and the VCO and a switch between the supply voltage and the first resistor);

N+1 switches being coupled between an input of the VCO and one of the N+1 nodes (Vref15, Vref14, Vref13, Vref0);

a test scan signal generator coupled to the N+1 switches so that a plurality of test scan signals control the N+1 switches when the PFD is disabled (paragraph 11);

and a scan-enable switch coupled between the N+1 switches and the input of the VCO to be turned on when the PFD is disabled (fig 1 (112)).

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Chien et al. to have a voltage generator with N resistors between supply and ground forming N+1 nodes between a supply switch and a pad, N+1 switches between an input of the VCO and one of the nodes, a test signal generator, and a scan enable switch as taught by Huang et al. in order to generate stable reference voltages for different stages in a readout chain (paragraph 10).

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In regard to claim 29 and 37, Chien et al. does not specifically state input voltage is calculated with the formula $V_{cc} = V_{dd}/N * m$.

The formula to calculate the input voltage: $V_c = V_{dd}/N * m$ where V_c is the particular test input voltage, V_{dd} is the supply and m is an arbitrary integer between 0 and N including both 0 and N is obvious from the fig 1 of Huang et al. and basic voltage laws. If the all the resistors are equal and in series (which is the case), each resistor would have a voltage drop of V_{dd}/N , then you would multiply it by the node to be determined to find the output voltage for a particular node.\

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Chien et al. to use the formula $V_c = V_{dd}/N * m$ to calculate input voltage as taught by Huang et al. and basic voltage laws in order to correctly find the voltage being supplied.

7. Claims 25-28 and 33-36 are rejected under 35 U.S.C. 103(a) as being unpatentable over Chien et al. (6597249) in view of Huang et al. (Pub 2003/0071748) as applied to claim 22 and 30 above, and further in view of Sunter (6492798).

Chien et al. as modified lacks wherein at least one of the $N+1$ switches and the scan enable switch has a transmission gate comprising a p-channel field effect transistor and an n-channel field effect transistor.

Sunter teaches using a conventional CMOS transmission gate (NMOS and PMOS) for a switch (fig 5 (N1,P1; N2,P2); col 8 line 34-35).

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Chien et al. as modified to use a CMOS transmission gate as the switches as taught by Sunter in order to improve isolation when the switch is open (col 8 line 34-37).

8. Claim 38 is rejected under 35 U.S.C. 103(a) as being unpatentable over Chien et al. (6597249) in view of Huang et al. (Pub 2003/0071748) as applied to claim 30 above, and further in view of Imai et al. (4851712).

Chien et al. as modified lacks wherein the pad is coupled to an arbitrary input voltage and the supply switch is turned off, and wherein the test input voltage is equivalent to the arbitrary input voltage.

Imai et al. discloses a bias voltage generated by a bias generator and applied to a pad (col 4 line 31-34); also the voltage generator contains pads at different potentials (fig 8 (10,15,16,23)).

It would have been obvious to one with ordinary skill in the art at the time the invention was made for Chien et al. as modified to have the pad coupled to an arbitrary input voltage equivalent to the test voltage and have the supply switch off as the pad is supplying voltage as taught by Imai et al. in order to apply a DC bias to an input pulse signal (col 4 line 32-34).

Conclusion


9. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Ott (6294935) teaches a device for testing a phased-locked loop. Tuttle et al. (6442271) teaches wherein VCO voltage input is provided by a bias voltage generator instead of a PLL circuit when power is lost (phase detector is disabled). Anderson (5987085) teaches disabling the PFD when frequency lock occurs.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jeff Natalini whose telephone number is 571-272-2266. The examiner can normally be reached on M-F 8-5.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, N. Le can be reached on 571-272-2233. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

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